Phase diagram of silicon from atom istic simulations

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In this letter we present a calculation of the temperature-pressure phase diagram of Si in a range of pressures covering from 5 to 20 GPa and temperatures up to the melting point. The phase boundaries and triple points between the diam ond, liquid, -Sn and Si₃₄ clathrate phases are reported. We have employed e cient simulation techniques to calculate free energies and to numerically integrate the Clausius-Clapeyron equation, combined with a tight binding model capable of an accuracy comparable to that of rst-principles methods. The resulting phase diagram agrees well with the available experimental data.

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Tem perature-pressure phase diagram s charter the regions of stability of the di erent allotropes of a m aterial. The confection of phase diagram shas been a long standing objective of experim ental physics, chem istry and m aterials science. However, to date, the phase diagram s ofm ost m aterials rem ain relatively unknown beyond the dom ain of norm al conditions, because of the technical challenge of performing accurate phase behavior studies in conditions of extrem e tem peratures and/or pressures. Reliable rst principles electronic structure calculations [1] have the potential to be of great assistance in this problem, and indeed they have proved their value with impressive demonstrations of their capabilities, such as the calculation of the melting curve of iron down to the pressure regime of the Earth's core [2], that of aluminum [3], or or that of hydrogen in a similar range of pressures [4]. But such calculations, which employ either free energy evaluation techniques like therm odynam ic integration, or directly address phase coexistence by explicitly simulating the interface, are computationally dem anding, and by no means routine. The twophase method, in particular, requires large simulation cells where the two phases can be monitored in coexistence, and it is only directly applicable to solid-liquid equilibria. Nevertheless, in recent years several simulation techniques have been developed which now make free energy calculations [5, 6] and phase boundary determ ination [7] much more accessible. In this letter we demonstrate the potential of these novel techniques by using them to obtain, entirely from atom istic simulations, the phase diagram of Siin a wide range of tem peratures and pressures.

In spite of being one of the most extensively studied materials, the phase diagram of Si is not accurately known. As many as eleven phases other than diam ond have been identied at high pressures [8], with at least six of them being thermodynamically stable in some temperature-pressure domain. It is now also clearly established [9] that other phases become stable at negative pressures: the so called clathrate phases [10], of which

Siz4 (also known as Siz46) has interesting sem iconducting properties [11] of its own. In Si, as in many other m aterials, computer simulations have been a great aid in identifying, and som etim es even predicting [12, 13] the occurrence of certain phases, but they have not been much used to help establishing the lim its of stability of the dierent phases except at zero tem perature [14] or zero pressure [15, 16]. In this letter we calculate the phase diagram of Sientirely from atom istic simulations, for tem peratures ranging between 0 and 1700 K, and for pressures in the range 5 to 20 G Pa. W e have considered four di erent phases in this tem perature-pressure region, namely the diam ond structure (SiI), the -Sn phase (II), Si_{34} (C) and the liquid phase (L), and provide the ve corresponding coexistence curves between these, as well as estimates for the location of the two triple points to be found in this area of the phase diagram .

In a recent study [17], we have shown that certain tight binding [18] models, such as those of K won et al. [19] and Lenosky et al. [20], are capable of providing very accurate descriptions not only of the structural properties of Si, but m ore in portantly of the therm al properties too. In fact, these two models predict a melting temperature at zero pressure which is in better agreem ent with the experim ental value than that provided by rst principles calculations [15, 16]. The deciding factor between the Kwon and Lenosky models is that only the latter correctly predicts a pressure-induced transition from the I to II phase [20]. All calculations reported below were carried out using supercells containing 128 Siatom s, except in the case of SiC , where a supercell of 136 atom s was in posed by the structure. Four special k-points [21] were used to sample the Brillouin zone and provided a su cient degree of convergence even for the metallic phases (II and L). All calculations were perform ed with the Trocadero code [22].

Let us now brie y describe the procedure adopted for determ ining the phase diagram. Firstly, for all pairs of phases for which a phase boundary is sought, a coexistence point along the boundary must be found, i.e. a tem -

Phase boundary	P ressure	Tem perature	dT /dP
	(GPa)	(K)	(K GPa ¹)
I{L	0	1551 66	16
		(1687 ^a)	(33 ^a)
II{L	10	1230 25	40
C {L	0	1424 57	73
		(1473 ^b)	
I{II	15 : 5 0 : 4	500	200
	(10:4 12:4°)	(573 [°])	
I{C	2:47 0:03	500	10 ⁴

^a R eference 8, ^b reference 9, ^c reference 25.

TABLE I: Coexistence points obtained between the di erent phases considered in this study. Experim entaldata is given in parenthesis when available. These points were later used as starting initial conditions for dynam ical C lausius-C lapeyron integration. The local slope of the corresponding coexistence line is also given.

perature and pressure for which the G ibbs free energies of the two phases in question are equal. If the coexistence line has a sm all (in absolute value) pressure derivative, in order to locate the coexistence point it is better to x the pressure of both phases at som e convenient value, P, and to calculate the G ibbs free energy of each phase in a tem perature interval bracketing the coexistence tem perature, T_c, at xed pressure. This can be done em ploying the reversible scaling technique of de Koning et al. [6]. If, on the other hand, the phase boundary is expected to have a large (in absolute value) pressure derivative, as is common in solid-solid coexistence lines, it is more convenient to x the tem perature and to m on itor the G ibbs free energy of each phase as a function of pressure, which can be done with the adiabatic switching technique [5]. Once a coexistence point has been thus located, the rest of the phase boundary is obtained by solving num erically the Clausius-Clapeyron equation:

$$\frac{\mathrm{dT}_{\mathrm{c}}}{\mathrm{dP}} = \mathrm{T}_{\mathrm{c}} \frac{\mathrm{V}}{\mathrm{H}}; \qquad (1)$$

where T_c is the coexistence temperature at pressure P, and V and H are the di erence of volum es and enthalpies of the two phases, respectively. This was done using the dynam ical scheme of de K oning and cow orkers [7]. All the above techniques require to simulate the system under isotherm al-isobaric conditions, and this was done as described by H emandez [23]. Following the scheme outlined above, we proceeded to locate initial coexistence points along the phase boundaries between the diam ond{liquid (I{L), -Sn{liquid (II{L), clathrate{liquid (C {L), diam ond{clathrate (I{C) and diam ond{ -Sn (I{II) phases. Further calculations were carried out at the found coexistence points in order to quantify the errors incurred in our estim ations of those conditions. For coexistence temperatures at xed pressure the error can be estimated from $T_c = S$ [24], where G is the error in the G ibbs free energy di erence, and S is the entropy change. For coexistence pressures at xed temperature, the error can be estimated from P = G = V, where V is the change of volume. A s well as error estimates, these calculations allowed us to obtain the values of the pressure derivatives of each phase boundary at the coexistence point from Eq. (1). Table (I) lists the locations of the di erent coexistence points, together with their estimated errors and the local pressure derivatives of the corresponding coexistence lines.

Our calculated zero-pressure melting point for Si-I (1551 K) is in reasonably good agreem ent with the accepted experimental value of 1687 K [8]. Although the di erence between these values m ay appear to be large, we note that density functional theory (DFT) calculations using the local density approximation (LDA) for the exchange-correlation energy predict values in the range 1300-1350 K [15, 16], and 1492 50 K when a generalized-gradient approximation (GGA) is used instead [16]. Comparison with our own previous estimation using the sam e m odel [17] gives a di erence of 30 K, within our error bars for the melting temperature, although we regard the present value as more accurate. In agreem ent with experim ents and with DFT calculations we obtain a negative slope for the phase boundary. The melting of (metastable) Si-II at 10 GPa is found to occur at 1230 K. This tem perature is already higher than the experim entalestim ate of the I{ II{L triple point tem perature [25], but is consistent with our own prediction for this triple point (see below). Like the I phase, C has a melting line with a negative slope. For this phase we predict a melting temperature at zero pressure of 1424 K, which is only 50 K below the experimentally measured value at this pressure [9], and also in good agreement with the calculated value of W ilson & M dM illan [27]. As for the coexistence pressure between Si-I and Si-II at 500 K, 15.5 GPa, it is larger than the experim ental values, 10.4-12.4 GPa at 573 K [25], but we note again that DFT-LDA calculations predict a value of 8 GPa [14] at zero tem perature, while recent quantum M onte C arlo calculations place it at 16.5 GPa [28]. At the sam e tem perature, the I{C coexistence point is found at 2:47 GPa, in good agreem ent with experim entalm easurem ents [9] and with both empirical potential simulations [27] and rst principles calculations [26].

Taking as starting conditions the coexistence points thus located, we then proceeded to run dynamical Clausius-Clapeyron [7] integration calculations, thereby obtaining the sought phase boundaries. Fig. (1) shows our calculated phase diagram for Si, and constitutes the central result of this work. For com parison, Fig. (1) also shows a summary of recent experimental observations from Voronin et al. [25], Hu et al. [30] and M cM illan [9]. As can be seen, the calculated phase diagram captures all the main features of the experim ental data with surprising delity. Nevertheless, there are dierences in the details which are mostly attributable to minor shortcom ings in the Lenosky tight-binding model.

The I{L coexistence line has, as previously mentioned, a negative pressure derivative, which increases slightly toward larger negative values as the pressure is raised. This is in agreem ent with experim ental observations by Voronin et al. [25] that suggest this behavior, although the pressure derivative predicted by the Lenosky model for this phase boundary is too small. An independent error estimate of the melting line away from the starting point of the dynam ical C lausius-C lapeyron integration calculation was obtained at a point of coordinates T = 1385 K and P = 8 GPa. We found an uncertainty of 95 K, which is not signi cantly worse than that of the zero-pressure melting point. The I{L melting line meets the I{ II phase boundary at a tem perature Т 1290 K and P 10:9 GPa, according to our results. The experim ental coordinates of this triple point are not accurately known, though a recent estimate by Voronin et al. [25] puts it at T = 1003 20 K and P = 10:502 GPa. Compared with this best experin ental estim ate, our triple point tem perature is som ewhat too high (by nearly 300 K), consistent with the fact that $dT_c = dP$ for the I{L melting line is too small in absolute value. How ever, we emphasize that the estimate of Voronin et al. is a low er bound; if one assumes that the I{ L value of dT = dP remains constant and equal to its zero pressure value, then at 10.5 GPa the triple point tem perature should be 1340 K, which is much closer to our gure. Thus, it is very likely that our triple point tem perature and that of Voron in et al. provide upper and lower bounds respectively for the true value. The agreem ent in the value of the pressure coordinate is much better (in fact, within our error estim ate for the I{ II phase boundary), but must be understood as som ewhat fortuitous, resulting from error cancellation between a I{II coexistence pressure at 500 K which is slightly too high, and a value of $dT_c=dP$ for the I{II phase boundary which is most likely smaller than the experimental one. Nevertheless, it should be pointed out that, to our know ledge, this is the rst prediction from atom istic simulations of the location of the of the I{II{L triple point of Si. We have also calculated the II{L phase boundary, starting from a tem perature and pressure where both the II and L phases are m etastable. Indeed, the II{L coexistence line crosses the I{ II and I{ L boundaries very close to the point where the I{L and I{II boundaries cross, a good indication of the internal consistency of our calculations.

The I{II phase boundary has, as expected, a large pressure derivative, of negative sign. Experim ental observations [25] seem to agree with this nding, although data is only available at large tem perature intervals, and it is not possible at present to com pare with an experim ental value of the pressure derivative. In any case,

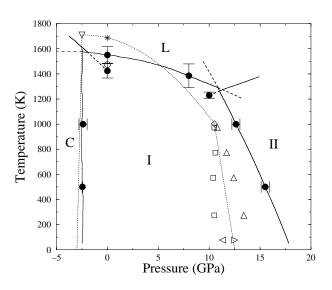


FIG.1: Silicon phase diagram. The continuous and dashed lines indicate the calculated phase diagram . D ashed curves indicate phase boundaries in regions where the separated phases are m etastable, while continuous black curves separate therm odynam ically stable phases; uncertainty bounds estim ated at specic points of the phase diagram (marked by lled circles) are provided by the error bars. For comparison purposes, a schematic phase diagram summarizing the experim ental data is shown with dotted lines, and experimental data at specic temperatures and pressures is shown in the form of empty symbols. The asterisk corresponds to the zeropressure melting point of phase I, 1687 K [8]; the circle is the zero-pressure melting point of the (metastable) C phase, at 1473 K [9]; the diam ond is the I{II{L triple point, with estim ated coordinates of 1003 20 K and 10:5 0:2 G Pa [25]; em pty squares and triangles indicate the pressures at which the II phase was rst observed and where the I phase ceased to be detected, respectively, in the experiments of Voronin et al. [25]; left and right pointing triangles give the sam e inform ation as obtained by Hu et al. [30]; nally, the downward pointing triangle is the estim ated I{C {L triple point, at 1710 K and 2:5 G Pa [9].

it can be concluded that, as it happened with the I{L melting curve, the pressure derivative of the I{II coexistence line is probably not as large as the experimental one. This can be seen from the fact that both coexistence pressures at T = 500 K and in the lim it T ! 0 K are severalGPa higher than the experim ental coexistence pressures at sim ilar tem peratures, while our pressure coordinate for the I{ II{ L triple point agrees quite wellw ith the experim ental value. It is worth noting that the coexistence pressure at T ! 0 K deduced from the calculated I{ II phase boundary (18.1 GPa) is very close to the value obtained by calculating the enthalpies of both phases at T = 0 K (18.5 GPa), which serves as another internal consistency check for our calculations. To further validate our results, we perform ed an error estim ation of the coexistence pressure at 1000 K . O ur results indicate that

the coexistence pressure predicted by the phase boundary at that tem perature (12.6 GPa) is accurate to within 0.4 GPa.

The I{C phase boundary we have obtained is nearly a vertical line at P 2:5 GPa. At 500 K our calculated coexistence point occurred at a pressure of 2:47 0:02 GPa [see Table (I)]. At 1000 K, we calculated a second coexistence point to double check the phase boundary calculation, obtaining a pressure of 2:4 0:4 GPa, to be compared with a value of 2:5 GPa according to our calculated phase boundary. The pressure derivative of this phase boundary is so large (10^4 K/GPa in absolute value) as to make it virtually impossible to predict its sign with any accuracy. This is a manifestation of the fact that at coexistence, not only the G ibbs free energies of the two phases are the same, but also their enthalpies are nearly equal. This in turn in plies that the entropies of the I and C phases are very sim ilar at coexistence conditions. The I{C and I{L boundaries cross at Т 1576 K and P 2:48 GPa, marking within our error bars the coordinates of the I{C {L triple point. W ison & M cM illan [27] have estim ated the location of this triple point to be 1750 K and 1:5 GPa, from two-phase coexistence calculations employing the Stillinger-W eber potential [29]. Experim ental estim ates [9] suggest that the triple point may actually be closer to 1710 K and

2.5 GPa. Again, we note that our predicted tem perature coordinate is too low by about 100–150 K, consistent with our underestim ation of the I m elting tem perature at zero pressure, while the pressure coordinate is closer to the experim entalestim ation. The C {L m elting line is alm ost straight, with a negative slope of 73 K/GPa; it crosses the I{L m elting line slightly to the right of the point where the latter is crossed by the I{C boundary, but their separation is within our estim ated error bars.

Thus it is seen that, in spite of its sim plicity and sem iempirical nature, the Lenosky model provides a fairly good description of the phase diagram of Si, being probably as accurate as could be expected of rst principles calculations. We have obtained ve phase boundaries and two triple points between four phases of the silicon phase diagram, in reasonable agreem ent with the known experimental data. The simulation techniques employed in this study to calculate free energies and to obtain coexistence curves are straight forward and e cient, and can equally well be used in combination with rst principles methods. It can be concluded, then, that the combination of techniques used here brings about the possibility of obtaining entire phase diagram s of com plex materials com pletely ab initio.

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